Source-Measure Unit High Voltage Source-Measure Unit High Current Source-Measure Unit



Four instruments in one (voltage

source, voltage measure, current

source, current measure)

1100V source and measure

Standard and custom sweep

capability including pulse

1000 source/measurements

1A source and measure

sensitivity

(237 only)

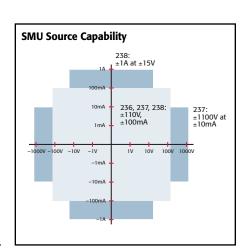
(238 only)

per second

The 236, 237, and 238 Source-Measure Units (SMU) are fully programmable instruments, capable of sourcing and measuring voltage or current simultaneously. These systems are really four instruments in one: voltage source, current source, voltage measure, and current measure.

Applications

These instruments address a wide variety of applications, including the characterization of semiconductor devices and the measurement of leakage currents or insulation resistance. They are particularly useful as source and measuring instruments in automated test equipment (ATE).



Wide Dynamic Range

The Model 236 will source voltage from $100\mu V$ to 110V, and current from 100fA to 100mA. It can also measure voltage from 10µV to 110V and current from 10fA to 100mA. The Model 237 offers the same capabilities with a decade enhancement in voltage source and measure

(1100V). In this higher voltage range, current source and measure is 10mA maximum. The Model 238 offers a decade enhancement in current source and measure (1A). In this higher current range, voltage source and measure is 15V maximum.

Selectable Sweeps of Voltage and Current

Creating custom sweeps of voltage or current is facilitated by the use of three waveform operations: CREATE, APPEND, and MODIFY. These allow the user to select waveform parameters, change any points in a waveform previously

Fully-Guarded Four-Terminal Measurements

The Model 236, 237, and 238 outputs and inputs are fully guarded, and the units are configured to allow four-terminal measurements. Two-terminal measurements are also available for more standard test procedures. These outputs can be floated up to ± 200 V from ground.

10fA, 10µV measurement

The 236, 237, and 238 can be programmed to perform source-measurements as a function of a stepped voltage or current. Voltage and current can be swept linearly, logarithmically, or pulsed. The START, STOP, STEP method of setting sweep parameters allows operators to become proficient at using the instrument very quickly. Sweep parameters may be appended (APPEND key) to obtain more complex test sequences.

combine multiple waveforms, and select and created or appended.

Ordering Information

236 **Source-Measure Unit High Voltage Source-**237

Measure Unit

High Current Source-238 **Measure Unit**

These products are available with an Extended Warranty.

7078-TRX-10 3-Slot Low Noise Triax Cables, 3m (10 ft) (2) 236-ILC-3 Interlock Cable. 3m (10 ft) 237-ALG-2 Low Noise Triax

Cable, 2m (6.6 ft)

ACCESSORIES AVAILABLE

Four quadrant source operation

Internal 1000-reading memory

CABLES AND CONNECTORS

237-TRX-NG 3-Slot Triax to 3-Lug Female Triax Connector 7078-TRX-3 3-Slot, Low Noise Triax Cable, 0.9m (3 ft) 7078-TRX-20 3-Slot, Low Noise Triax Cable, 6m (20 ft)

RACKS & RACK MOUNT KITS

Fixed Rack Mount Kit 1938 1939 Slide Rack Mount Kit

SOFTWARE

METRICS-ICS-35 I-V C-V Curve Tracer Software TestPoint™ Test Development Software

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www.keithley.com



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Source-Measure Unit High Voltage Source-Measure Unit High Current Source-Measure Unit

SOURCE-DELAY-MEASURE CYCLE:



Default Delay: Fixed delay for instrument settling.

User Delay: Additional delay for device under test or system capacitance.

MEASURE: Integration Time

Fast	416	μ s	4-digit resolution
Medium	4	ms	5-digit resolution
Line Cycle	16.67	ms (60 Hz)	5-digit resolution
	20.00	ms (50 Hz)	

EXECUTION SPEED

MINIMUM SOURCE-DELAY-MEASURE CYCLE TIME: 1ms.
RESPONSE TO IEEE-488 COMMAND (as a source): 25ms.
MEASUREMENT RATE: 1ms per point into internal buffer.
CONTINUOUS MEASUREMENT SPEED (source DC value over

IEEE-488 bus): 110 readings per second. **TRIGGER LATENCY TIME:** <2ms.

GENERAL

 $\textbf{LOAD CAPACITANCE:} \ Stable \ into \ 20,000 pF \ typical.$

REMOTE SENSE: Corrects for up to 2V drop in each output lead. Maximum $1k\Omega$ per sense lead for rated accuracy. Residual output resistance (as a voltage source) is 0.5Ω .

GUARD: Output Resistance: ≤ 12kΩ. Maximum Output Current: ±2mA.

ISOLATION (Output LO to chassis): Typically $> 10^{10}\Omega$ in parallel with 500pF (650pF on Model 238).

MAXIMUM COMMON MODE VOLTAGE: 200V

Offset Relative to Output HI: ±2mV max.

CONNECTORS: Outputs: 3-lug triax.

Trigger Input/Output: BNC.

Interlock: 3-pin miniature DIN.

TEMPERATURE COEFFICIENT (0°-18°C & 28°-50°C): $\pm (0.1 \times \text{applicable accuracy specification})$ °C.

ENVIRONMENT:

Operating: 0° – 50° C, 70° relative humidity up to 35° C. Linearly derate 3° RH/°C, 35° – 50° C.

Storage: -25° to 65°C.

EMC: Conforms to European Union Directive 89/336/EEC.

SAFETY: Conforms to European Union Directive 73/23/EEC (meets EN61010-1/IEC 1010).

WARM-UP: One hour to rated accuracy.

COOLING: Internal fan forced air cooling.

 $\begin{array}{l} \textbf{POWER: } 105-125 \text{ or } 210-250 \text{V AC (external switch selectable)}, 90-110 \text{V and} \\ 180-220 \text{V version available. } 100 \text{VA max. (} 120 \text{VA max. on Model } 238 \text{)}. \end{array}$

DIMENSIONS, WEIGHT: 89mm high \times 435mm wide \times 448mm deep (3½ in \times 17½ in \times 17½ in). Net weight 9kg (19.75 lb).

VOLTAGE

VOLIAG		COLIDA	CE V		MEACUE	or v	
	(Max. STEP (1 Year,		ACCURACY (1 Year, 18°-28°C)	MEASURE V ACCURACY RESOLUTION(1 Year, 4-Digit 5-Digit 18°-28°C)			
236, 237	±1.1000 V ±11.000 V ±110.00 V	100 μV 1 mV 10 mV	$\pm (0.033\% + 650 \mu\text{V})$ $\pm (0.033\% + 2.4 \text{mV})$ $\pm (0.033\% + 24 \text{mV})$	100 μV 1 mV 10 mV	10 μV 100 μV 1 mV	$\pm (0.028\% + 300 \mu\text{V})$ $\pm (0.025\% + 1 \text{mV})$ $\pm (0.025\% + 10 \text{mV})$	
237 Only	±1100.0 V	100 mV	±(0.04 %+240 mV)	100 mV	10 mV	±(0.035%+100 mV)	
238 Only	±1.5000 V ±15.000 V ±110.00 V	100 μV 1 mV 10 mV	$\pm (0.033\% + 800 \mu\text{V})$ $\pm (0.033\% + 2.7 \text{mV})$ $\pm (0.033\% + 24 \text{mV})$	100 μV 1 mV 10 mV	$10 \mu V$ $100 \mu V$ $1 mV$	$\pm (0.028\% + 450 \mu\text{V})$ $\pm (0.025\% + 1 \text{mV})$ $\pm (0.025\% + 10 \text{mV})$	

COMPLIANCE: Bipolar current limit set with single value.

Maximum: ±100mA (except ±10mA on 1100V range in Model 237 and ±1A on 15V range in Model 238).

Minimum: ±1% of range, except 0.5% of 1.1V range. **Accuracy, Step Size:** Same as current source.

NOISE (p-p):

RANGE	0.1-10Hz	DC-20MHz	
110 V - 1100 V	< 3ppm of range	40 mV	
11 V (15 V on 238)	< 3ppm of range	15 mV	
1.1 V (1.5 V on 238)	<10ppm of range	15 mV	

WIDEBAND NOISE: 0.1 to 20MHz, 8mV p-p typical.

OVERSHOOT: <0.01% (110V step, 10mA range).

SETTLING TIME: <500µs to 0.01% (110V step, 10mA range).

NMRR: >60dB at 50 or 60Hz (LINE CYCLE integration time selected).

CMRR: >120dB at DC, 50 or 60Hz (LINE CYCLE integration time selected).

INPUT IMPEDANCE (as a voltmeter): $>10^{14}\Omega$ paralleled by <20pE

CURRENT

	SOURCE I			MEASURE I			
	RANGE (Max. Value)	STEP SIZE	ACCURACY (1 Year, 18°–28°C)	RESOLU 4-Digit	UTION 5-Digit	ACCURACY (1 Year, 18°-28°C)	
All	±1.0000 nA	100 fA	±(0.3 %+ 450 fA)	100 fA	10 fA	±(0.3 % + 100 fA) ¹	
	±10.000 nA	1 pA	±(0.3 %+ 2 pA)	1 pA	100 fA	$\pm (0.3 \% + 1 \text{ pA})$	
	±100.00 nA	10 pA	±(0.21%+ 20 pA)	10 pA	1 pA	$\pm (0.21 \% + 6 pA)$	
	$\pm 1.0000~\mu A$	100 pA	±(0.05%+ 200 pA)	100 pA	10 pA	$\pm (0.04 \% + 60 \text{ pA})$	
	$\pm 10.000~\mu \text{A}$	1 nA	±(0.05%+ 2 nA)	1 nA	100 pA	$\pm (0.035\% + 700 \text{ pA})$	
	$\pm 100.00~\mu A$	10 nA	±(0.05%+ 20 nA)	10 nA	1 nA	$\pm (0.035\% + 6 \text{ nA})$	
	±1.0000 mA	100 nA	±(0.05%+ 200 nA)	100 nA	10 nA	$\pm (0.035\% + 60 \text{ nA})$	
	±10.000 mA	$1\mu\mathrm{A}$	$\pm (0.05\% + 2 \mu\text{A})$	$1~\mu A$	100 nA	$\pm (0.038\% + 600 \text{ nA})$	
	±100.00 mA	$10 \mu\text{A}$	$\pm (0.1 \% + 20 \mu\text{A})$	$10 \mu A$	$1 \mu A$	$\pm (0.1 \% + 6 \mu A)$	
238 Only	±1.0000 A	$100\mu\mathrm{A}$	±(0.12%+ 700 nA)	$100~\mu\text{A}$	$10 \mu A$	$\pm (0.12 \% + 300 \mu A)$	

COMPLIANCE: Bipolar voltage limit set with single value.

Maximum: ±1100V (except ±110V in Model 238 and on 100mA range in Model 237).

Minimum: ±0.1% of selected current range.

Accuracy, Step Size: Same as voltage source.

NOISE (p-p of range): 0.1–10Hz: <3ppm (<20ppm on 1nA and 10nA ranges and on 1A range in Model 238).

OVERSHOOT: <0.01% typical (10mA step, $R_L = 10k\Omega$).

SETTLING TIME: ${<}500\mu s$ to 0.01% (10mA step, $R_L = 10k\Omega$).

OUTPUT R, C: $>10^{14}\Omega$ paralleled by <20pF (on 1nA range).

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 $^{^1}$ Offset specification applies for 23 $^{\circ}\text{C}$ $\pm 1^{\circ}\text{C}$ with suppression. Temperature coefficient 50fA/°C.

238 High Current Source-Measure Unit

SOURCE-MEASURE UNIT: Sources voltage while measuring current, or sources current while measuring voltage.

FUNCTION: Can be used as DC source or meter, sweep source, or full source-measure unit.

SOURCE-DELAY-MEASURE CYCLE:



Default Delay: Fixed delay for instrument settling.

User Delay: Additional delay for device under test or system capacitance.

MEASURE:

Integration Time		
Fast	416 µs	4-digit resolution
Medium	4 ms	5-digit resolution
Line Cycle	16.67 ms (60 Hz)	5-digit resolution
	20.00 ms (50 Hz)	_

Elapsed Time: Measures and stores time from sweep trigger to measurement complete for each step of sweep.

RANGING:

Source: Auto-ranging through keypad entry; fixed range selection using rotary dial and SELECT keys (DC function). Fully programmable in SWEEP function.

Measure: Auto or fixed range. Fixed range selection made by choice of COMPLIANCE value.

FILTER: Takes n measurements, calculates and outputs average (n = 2, 4, 8, 16, or 32, selectable).

SUPPRESS: Subtracts displayed measurement from subsequent readings.

MENU: DC Measurement Delay, Default Delay On/Off, Local/Remote Sense, 50/60Hz, IEEE Address, Self Tests.

DATA ENTRY: Numeric keypad or detented rotary dial.

TRIGGER:

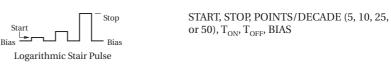
Input and Output: Set for any phase of SOURCE-DELAY-MEASURE sequence or trigger output at end of sweep.

Origin: Internal, External (including front panel MANUAL TRIGGER button), IEEE-488 bus (TALK, GET, "X").

MEMORY: Stores one full sweep (up to 1000 points) of source, delay, and measure values, elapsed times, and sweep parameters. Lithium battery backup.

INTERLOCK: Use with test fixture or external switch. Normally closed; open puts instrument in standby.

SWEEP WAVEFORMS DESCRIPTION LEVEL, COUNT (number of DELAY-MEASURE cycles), DELAY, BIAS Fixed Level START, STOP, STEP, DELAY, BIAS Start Bias Bias Linear Stair START, STOP, POINTS/DECADE (5, 10, 25, or 50), DELAY, BIAS Logarithmic Stair LEVEL, COUNT, T_{ON}, T_{OFF}, BIAS Pulse START, STOP, STEP, T_{ON} , T_{OFF} , BIAS Linear Stair Pulse



WAVEFORM OPERATORS DESCRIPTION Allows selection of waveform parameters. Generates all source values. Create Combines multiple waveforms and adds new points to those already in memory. Select and change any points in a previously created (or appended) waveform.

Modify

238 High Current Source-Measure Unit

VOLTAG	E	SOURC	CEV		MEASUF	REV
	RANGE (Max. Value)	STEP SIZE	ACCURACY (1 Year, 18°–28°C)	RESOL 4-Digit	UTION 5-Digit	ACCURACY ¹ (1 Year, 18°–28°C)
	±1.5000 V	100 μV	$^{\pm (0.033\% \ +800 \ \mu V}_{+ \ [I_O/I_{FS}] \times 600 \mu V)^2}$	100 μV	10 μV	$^{\pm (0.028\% + 450 \mu V}_{+ [I_{O}/I_{FS}] \times 600 \mu V)^{2}}$
	$\pm 15.000\mathrm{V}$	1 mV	$\pm (0.033\% + 2.7 \text{mV})$	1 mV	100 μV	±(0.025%+ 1.3mV) ²
	±110.00 V	10 mV	$\pm (0.033\% + 24\text{mV})$	10 mV	1 mV	±(0.025%+ 10mV)

I_O = Output current; I_{ES} = Full scale on selected current range

COMPLIANCE: Bipolar current limit set with single value.

Maximum: $\pm 1A$ (± 100 mA on 110V range). **Minimum:** $\pm 1\%$ of selected voltage range. **Accuracy, Step Size:** Same as current source.

NOISE (p-p typical):

RANGE	0.1-10Hz
110 V	< 3ppm of range
15 V	< 3ppm of range
1.5V	<10ppm of range

WIDEBAND NOISE: 0.1 to 20MHz, 8mV p-p typical.

OVERSHOOT: <0.01% (110V step, 10mA range).

SETTLING TIME: <500µs to 0.01% (110V step, 10mA range).

NMRR: >60dB at 50 or 60Hz (LINE CYCLE integration time selected).

CMRR: >120dB at DC, 50 or 60Hz (LINE CYCLE integration time selected).

INPUT IMPEDANCE (as a voltmeter): $>10^{14}\Omega$ paralleled by <20pF.

CURRENT	SOURCE	I		MEASU	RE I
RANGE (Max.	STEP	ACCURACY (1 Year,	RESOI	UTION	ACCURACY ^{1,2} (1 Year,
Value)	SIZE	18°-28°C)	4-Digit	5-Digit	18°-28°C)
±1.0000 nA	100 fA	±(0.3 %+ 450 fA)	100 fA	10 fA	±(0.3 % + 100 fA) ²
±10.000 nA	1 pA	±(0.3 %+ 2 pA)	1 pA	100 fA	$\pm (0.3 \% + 1 \text{ pA})$
±100.00 nA	10 pA	±(0.21%+ 20 pA)	10 pA	1 pA	$\pm (0.21 \% + 6 pA)$
±1.0000 μA	100 pA	±(0.05%+ 200 pA)	100 pA	10 pA	$\pm (0.04 \% + 6 pA)$
±10.000 μA	1 nA	±(0.05%+ 2 nA)	1 nA	100 pA	±(0.035% + 700 pA)
±100.00 μA	10 nA	±(0.05%+ 20 nA)	10 nA	1 nA	$\pm (0.035\% + 6 \text{ nA})$
±1.0000 mA	100 nA	±(0.05%+ 200 nA)	100 nA	10 nA	$\pm (0.035\% + 60 \text{ nA})$
±10.000 mA	1 μΑ	$\pm (0.05\% + 2 \mu A)$	1 μΑ	100 nA	$\pm (0.038\% + 600 \text{ nA})$
±100.00 mA	10 μA	±(0.1 %+ 20 μA)	10 μΑ	1 μΑ	$\pm (0.1 \% + 6 \mu A)$
±1.0000 A	100 μΑ	±(0.12%+ 700 μA)	100 μΑ	10 μΑ	$\pm (0.12 \% + 300 \mu A)$

¹ Specifications apply for 5-digit resolution. For 4-digit resolution, all offset terms are 200ppm of range.

COMPLIANCE: Bipolar voltage limit set with single value.

Maximum: ±110V (±15V on the 1A range). Minimum: ±1% of selected current range. Accuracy, Step Size: Same as voltage source.

NOISE (p-p of range): 0.1-10Hz: <3ppm (<20ppm on 1nA, 10nA and 1A ranges).

OVERSHOOT: <0.01% typical (10mA step, $R_L = 10k\Omega$). SETTLING TIME: <500 μ s to 0.01% (10mA step, $R_L = 10k\Omega$). OUTPUT R, C: >10¹⁴ Ω paralleled by <20 μ F (on 1nA range).

EXECUTION SPEED

MINIMUM SOURCE-DELAY-MEASURE CYCLE TIME: 1ms. RESPONSE TO IEEE-488 COMMAND (as a source): 25ms.

MEASUREMENT RATE: 1ms per point into internal buffer.

CONTINUOUS MEASUREMENT SPEED (source DC value over IEEE-488 bus): 110 readings per second.

TRIGGER LATENCY TIME: <2ms.

IEEE-488 BUS IMPLEMENTATION

MULTILINE COMMANDS: DCL, LLO, SDC, GET, GTL, UNT, UNL, SPE, SPD.

UNILINE COMMANDS: IFC, REN, EOI, SRQ, ATN.

INTERFACE FUNCTIONS: SH1, AH1, T6, TE0, L4, LE0, SR1, RL1, PP0, DC1, DT1, C0, E1.

All front panel functions and setups are available over the IEEE-488 bus, in addition to Status, Service Request, Output Format, EOI, Trigger, and Terminator.

IEEE-488 address is set from the front panel menu.

GENERAL

LOAD CAPACITANCE: Stable into 20,000pF typical.

REMOTE SENSE: Corrects for up to 2V drop in each output lead. Maximum $1k\Omega$ per sense lead for rated accuracy. Residual output resistance (as a voltage source) is 0.5Ω .

GUARD:Output Resistance: ≤12kΩ. **Maximum Output Current:** ±2mA.

Open Circuit Offset Relative to Output HI: ±2mV max.

ISOLATION (Output LO to chassis): Typically >10 $^{10}\Omega$ in parallel with 650pE

MAXIMUM COMMON MODE VOLTAGE: 200V peak.

CONNECTORS:Outputs: 3-lug triax.

Trigger Input/Output: BNC.

Interlock: 3-pin miniature DIN.

TEMPERATURE COEFFICIENT (0°-18°C & 28°-50°C): ±(0.1 × applicable accuracy specification)/°C.

ENVIRONMENT:

Operating: 0° – 50° C, 70° relative humidity up to 35°C. Linearly derate 3% RH/°C, 35°– 50° C.

Storage: –25° to 65°C.

WARM-UP: One hour to rated accuracy.

COOLING: Internal fan forced air cooling.

POWER: 105–125 or 210–250V AC (external switch selectable), 90–110V and 180–220V version available. 120VA max.

DIMENSIONS, WEIGHT: 89mm high \times 435mm wide \times 448mm deep ($3\frac{1}{2}$ in \times 17\% in \times 17\% in). Net weight 9kg (19.75 lb).

ACCESSORIES SUPPLIED:

Model 7078-TRX-10: Triax to Triax Cable, 3m (10 ft.) (2 supplied) Model 236-ILC-3: Interlock Cable

ACCESSORIES AVAILABLE:

Model 8000-10: Equipment Rack for 3 SMUs (10 in.) Model 8000-14: Equipment Rack for 4 SMUs (14 in.)

 $^{^1}$ Specifications apply for 5-digit resolution. For 4-digit resolution add 100ppm of range. Assumes remote sense for I > 100 μA .

 $^{^2\,}$ On the 1A range use $[I_O/I_{FS}]\times 250\mu V$

² Offset specification applies for 23°C ± 1°C with suppression. Temperature coefficient 50fA/°C.